

# **LQ20N200CQ Qspeed**<sup>™</sup> Automotive Family

200 V, 20 A Common-Cathode Diode for Audio Automotive Applications

## **Product Summary**

I <sub>F(AVG)</sub> per diode	10	Α
$V_{RRM}$	200	V
Q <sub>RR</sub> (Typ at 125 °C)	48.4	nC
I <sub>RRM</sub> (Typ at 125 °C)	3.29	Α
Softness t <sub>b</sub> /t <sub>a</sub> (Typ at 125 °C)	0.34	

## **Pin Assignment**



# **RoHS Compliant**

Package uses Lead-free plating and "Green" mold compound Halogen free per IEC 61249-2-21.

### **General Description**

This device has the lowest  $Q_{RR}$  of any 200 V Silicon diode. Its recovery characteristics increase efficiency, reduce EMI and eliminate snubbers.

# **Applications**

- Automotive
  - · AEC-Q101 qualified
  - Fab, assembly and test certified to IATF 16949
  - ESD HBM classification H0

#### **Features**

- Low Q<sub>RR</sub>, Low I<sub>RRM</sub>, Low t<sub>RR</sub>
- Soft recovery

#### **Benefits**

- Increases efficiency
  - Eliminates need for snubber circuits
  - Reduces EMI filter component size and count
- Enables extremely fast switching

# **Absolute Maximum Ratings**

Absolute maximum ratings are the values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Symbol	Parameter	Conditions	Rating	Units
$V_{RRM}$	Peak repetitive reverse voltage $T_{J} = 25 \text{ °C}$		200	V
I <sub>F(AVG)</sub>	Average forward current Per Diode, $T_1 = 150$ °C, $T_C = 124$ °C		10	Α
		Per Device, $T_J = 150$ °C, $T_C = 124$ °C	20	Α
$I_{FSM}$	Non-repetitive peak surge current	etitive peak surge current Per Diode, 60 Hz, ½ cycle		Α
$I_{FSM}$	Non-repetitive peak surge current	Per Diode, $\frac{1}{2}$ cycle of t = 28 $\mu$ s Sinusoid, $T_C = 25$ °C		Α
T <sub>J</sub>	Operating junction temperature range		-40 to 150	°C
$T_{STG}$	Storage temperature		-55 to 150	°C
	Lead soldering temperature	Leads at 1.6mm from case, 10 sec	300	°C
$P_D$	Power dissipation $T_C = 25 \text{ °C}$		41.7	W

## **Thermal Resistance**

Symbol	Resistance from:	Conditions Ra		Units
D	lunction to case	Per Diode		°C/W
$R_{\theta JC}$	R <sub>OJC</sub> Junction to case	Per Device	1.5	°C/W

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# **Electrical Specifications** at $T_J = 25$ °C (unless otherwise specified)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
DC Chara	acteristics per diode						•
$I_{R}$	Reverse current per diode	V <sub>R</sub> = 200 V, T <sub>J</sub> = 25 °C		-	-	500	μА
		$V_R = 200 \text{ V, } T_J =$	125 °C	-	0.35	-	mA
$V_{F}$	Forward voltage per diode	I <sub>F</sub> = 10 A, T <sub>J</sub> = 25 °C		-	0.98	1.15	V
		$I_F = 10 A, T_J = 15$	I <sub>F</sub> = 10 A, T <sub>J</sub> = 150 °C		0.85	-	V
C <sub>J</sub>	Junction capacitance per diode	V <sub>R</sub> = 10 V, 1 MHz		-	38	-	pF
Dynamic	Dynamic Characteristics per diode						
t <sub>RR</sub>	Reverse recovery time,	$dI_F/dt = 200 A/\mu s$	T <sub>J</sub> = 25 °C	-	16	-	ns
	per diode	$V_R = 130 \text{ V},$ $I_F = 10 \text{ A}$	T <sub>J</sub> = 125 °C	-	23.5	-	ns
$Q_{RR}$	Reverse recovery charge,	$dI_F/dt = 200 A/\mu s$	T <sub>J</sub> = 25 °C	-	20	32	nC
	per diode	$V_R = 130 \text{ V},$ $I_F = 10 \text{ A}$	T <sub>J</sub> = 125 °C	-	48.4	-	nC
$I_{RRM}$	Maximum reverse	$dI_F/dt = 200 A/\mu s$	T <sub>J</sub> = 25 °C	-	2.1	3.05	Α
	recovery current, per diode	$V_R = 130 \text{ V},$ $I_F = 10 \text{ A}$	T <sub>J</sub> = 125 °C	ı	3.29	-	А
S	Coffman th	$dI_F/dt = 200 A/\mu s$	T <sub>J</sub> = 25 °C	-	0.41	-	
	Softness per diode = $\frac{t_b}{t_a}$		T <sub>J</sub> = 125 °C	-	0.34	-	

**Note to component engineers**: Q-Series diodes employ Schottky technologies in their design and construction. Therefore, component engineers should plan their test setups to be similar to traditional Schottky test setups. (For further details, see application note AN-300.)

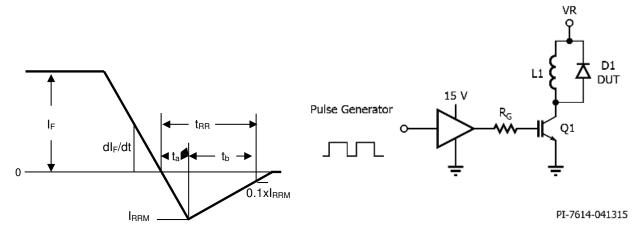
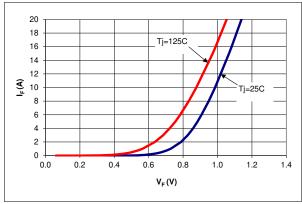


Figure 1. Reverse Recovery Definitions

Figure 2. Reverse Recovery Test Circuit

# Electrical Specifications at $T_1 = 25$ °C (unless otherwise specified)



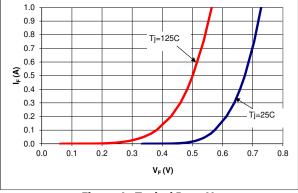
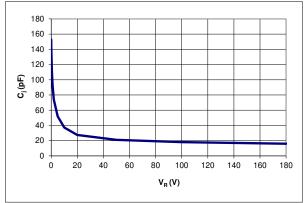


Figure 3. Typical I<sub>F</sub> vs. V<sub>F</sub>

Figure 4. Typical I<sub>F</sub> vs. V<sub>F</sub>



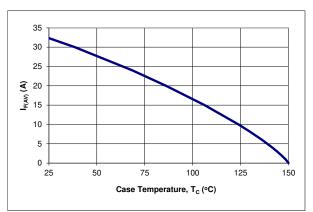
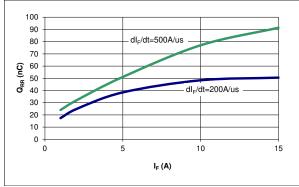


Figure 5. Typical C<sub>J</sub> vs. V<sub>R</sub>

Figure 6. DC Current Derating Curve



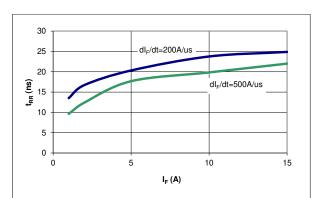
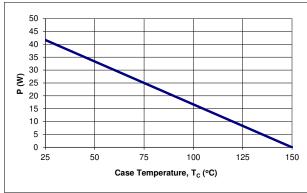


Figure 7. Typical  $Q_{RR}$  vs.  $I_F$  at  $T_J = 125$  °C

Figure 8. Typical t<sub>RR</sub> vs. I<sub>F</sub> at T<sub>J</sub> =125 °C





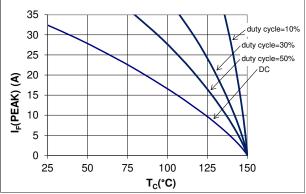


Figure 10.  $I_F$  (Peak) vs. TC, f = 70 kHz

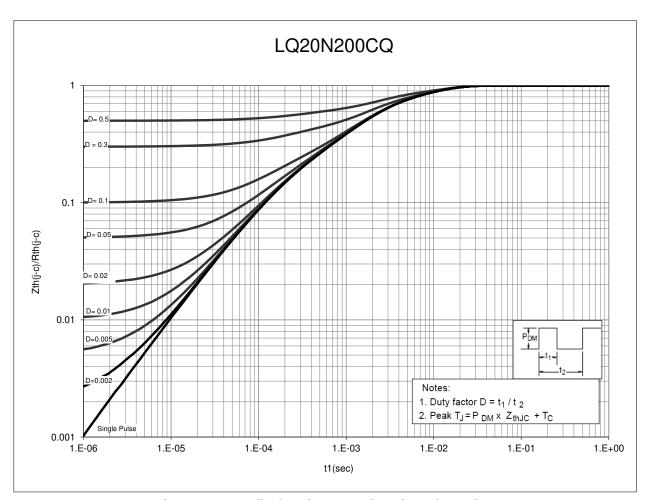
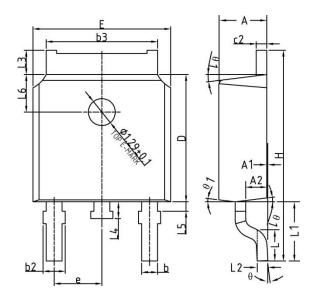


Figure 11. Normalized Maximum Transient Thermal Impedance

# **Dimensional Outline Drawings**

TO-252 DPAK



	Millimeters		
Dim	MIN MAX		
Α	2.20	2.38	
<b>A1</b>	0	0.10	
A2	0.90	1.10	
b	0.72	0.85	
b2	0.72	0.90	
b3	5.13	5.46	
c2	0.47	0.60	
D	6.00	6.20	
E	6.50	6.70	
е	2.186	2.386	
Н	9.80	10.40	
L	1.40	1.70	
L1	2.90	REF	
L2	0.51	BSC	
L3	0.90	1.25	
L4	0.60	1.00	
L5	0.15	0.75	
L6	1.80 REF		
Θ	0° 8°		
Θ1	5° 9°		

**Soldering time and temperature:** This product has been designed for use with high-temperature, lead-free solder. The component leads can be subjected to a maximum temperature of 300 °C, for up to 10 seconds. See Application Note AN-303, for more details.

# **Ordering Information**

Part Number	Package	Packing
LQ20N200CQ	TO-252 DPAK	2500 units/reel

The information contained in this document is subject to change without notice.

LQ20N200CQ

Revision	Notes	Date
1.1	Code A release.	03/19

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